

August 1991

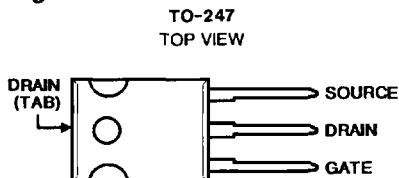
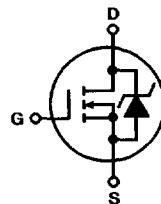
**Features**

- 12A and 14A, 450V - 500V
- $r_{DS(on)} = 0.4\Omega$  and  $0.5\Omega$
- Single Pulse Avalanche Energy Rated\*
- SOA is Power-Dissipation Limited
- Nanosecond Switching Speeds
- Linear Transfer Characteristics
- High Input Impedance

**Description**

The IRFP450, IRFP451, IRFP452, and IRFP453 are n-channel enhancement-mode silicon-gate power field-effect transistors. IRFP450R, IRFP451R, IRFP452R and IRFP453R types are advanced power MOSFETs designed, tested, and guaranteed to withstand a specified level of energy in the breakdown avalanche mode of operation. All of these power MOSFETs are designed for applications such as switching regulators, switching converters, motor drivers, relay drivers, and drivers for high-power bipolar switching transistors requiring high speed and low gate-drive power. These types can be operated directly from integrated circuits.

The IRFP types are supplied in the JEDEC TO-247 plastic package.

**Package**

**Terminal Diagram**
**N-CHANNEL ENHANCEMENT MODE**

**Absolute Maximum Ratings (TC = +25°C), Unless Otherwise Specified**

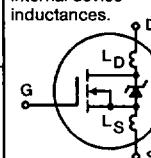
	IRFP450 IRFP450R	IRFP451 IRFP451R	IRFP452 IRFP452R	IRFP453 IRFP453R	UNITS
Drain-Source Voltage (1) .....	V <sub>DS</sub>	500	450	500	V
Drain-Gate Voltage (R <sub>GS</sub> = 20kΩ) (1).....	V <sub>DGR</sub>	500	450	500	V
Continuous Drain Current					
T <sub>C</sub> = +25°C .....	I <sub>D</sub>	14	14	12	A
T <sub>C</sub> = +100°C .....	I <sub>D</sub>	8.8	8.8	7.9	A
Pulsed Drain Current (3) .....	I <sub>DM</sub>	56	56	48	A
Gate-Source Voltage .....	V <sub>GS</sub>	±20	±20	±20	V
Maximum Power Dissipation					
T <sub>C</sub> = +25°C .....	P <sub>D</sub>	180	180	180	W
Linear Derating Factor.....		1.44	1.44	1.44	W/°C
Inductive Current, Clamped .....	I <sub>LM</sub>	52	52	48	A
(See Figure 14, L = 100µH)					
Single Pulse Avalanche Energy Rating (4).....	E <sub>AS</sub> *	860	860	860	mJ
Operating and Storage Junction .....	T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	-55 to +150	-55 to +150	°C
Temperature Range					
Maximum Lead Temperature for Soldering .....	T <sub>L</sub>	300	300	300	°C
(0.063" (1.6mm) from case for 10s)					

**NOTES:**

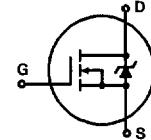
1. T<sub>J</sub> = +25°C to +150°C.
2. Pulse Test: Pulse width  $\leq 300\mu s$ , Duty Cycle  $\leq 2\%$ .
3. Repetitive rating: Pulse width limited by maximum junction temperature.  
See Transient Thermal Impedance Curve (Figure 5).
4. V<sub>DD</sub> = 50V, starting T<sub>J</sub> = +25°C, L = 7.9mH, R<sub>GS</sub> = 25Ω, I<sub>PEAK</sub> = 14A. See Figure 15.

\*R Suffix Types Only

Electrical Characteristics  $T_C = 25^\circ\text{C}$ , Unless Otherwise Specified

CHARACTERISTIC	SYMBOL	TEST CONDITIONS	LIMITS			UNITS	
			MIN	TYP	MAX		
Drain-Source Breakdown Voltage IRFP450/452, IRFP450R/452R IRFP451/453, IRFP451R/453R	BV <sub>DSS</sub>	$V_{GS} = 0V, I_D = 250\mu\text{A}$	500	-	-	V	
Gate Threshold Voltage			450	-	-	V	
Gate-Source Leakage Forward	$I_{GSS}$	$V_{GS} = 20V$	-	-	500	nA	
Gate-Source Leakage Reverse	$I_{GSS}$	$V_{GS} = -20V$	-	-	-500	nA	
Zero Gate Voltage Drain Current	$I_{DS}$	$V_{DS} = \text{Max Rating}, V_{GS} = 0V$	-	-	250	$\mu\text{A}$	
		$V_{DS} = \text{Max Rating} \times 0.8, V_{GS} = 0V, T_J = +125^\circ\text{C}$	-	-	1000	$\mu\text{A}$	
On-State Drain Current (Note 2) IRFP450/451, IRFP450R/451R IRFP452/453, IRFP452R/453R	$I_{D(ON)}$	$V_{DS} > I_{D(ON)} \times r_{DS(ON)}$ Max, $V_{GS} = 10V$	14	-	-	A	
			12	-	-	A	
Static Drain-Source On-State Resistance (Note 2) IRFP450/451, IRFP450R/451R IRFP452/453, IRFP452R/453R	$r_{DS(ON)}$	$V_{GS} = 10V, I_D = 7.9A$	-	0.3	0.4	$\Omega$	
			-	0.4	0.5	$\Omega$	
Forward Transconductance (Note 2)	$g_{fs}$	$V_{DS} \geq 50V, I_D = 7.9A$	9.3	13.8	-	S(Ω)	
Input Capacitance	$C_{ISS}$	$V_{GS} = 0V, V_{DS} = 25V, f = 1.0\text{MHz}$	-	2000	-	pF	
Output Capacitance	$C_{OSS}$	See Figure 10	-	400	-	pF	
Reverse Transfer Capacitance	$C_{RSS}$		-	100	-	pF	
Turn-On Delay Time	$t_{d(ON)}$	$V_{DD} = 250V, I_D = 14A, R_G = 6.1\Omega$	-	16	27	ns	
Rise Time	$t_r$	See Figure 16. (MOSFET switching times are essentially independent of operating temperature)	-	45	66	ns	
Turn-Off Delay Time	$t_{d(OFF)}$		-	68	100	ns	
Fall Time	$t_f$		-	41	60	ns	
Total Gate Charge (Gate-Source + Gate-Drain)	$Q_g$	$V_{GS} = 10V, I_D = 14A, V_{DS} = 0.8V$ Max Rating. See Figure 17 for test circuit.	-	82	130	nC	
Gate-Source Charge	$Q_{gs}$	(Gate charge is essentially independent of operating temperature.)	-	12	-	nC	
Gate-Drain ("Miller") Charge	$Q_{gd}$		-	42	-	nC	
Internal Drain Inductance	$L_D$	Measured between the contact screw on header that is closer to source and gate pins and center of center of die.	Modified MOSFET symbol showing the internal device inductances. 	-	5.0	-	nH
Internal Source Inductance	$L_S$	Measured from the source lead, 6mm (0.25") from header and source bonding pad.		-	12.5	-	nH
Junction-to-Case	$R_{0JC}$		-	-	0.70	$^\circ\text{C}/\text{W}$	
Case-to-Sink	$R_{0CS}$	Mounting surface flat, smooth and greased	-	0.10	-	$^\circ\text{C}/\text{W}$	
Junction-to-Ambient	$R_{0JA}$	Free air operation	-	-	30	$^\circ\text{C}/\text{W}$	

## Source Drain Diode Ratings and Characteristics

Continuous Source Current (Body Diode)	$I_S$	Modified MOSFET symbol showing the integral reverse P-N junc. rectifier. 	-	-	14	A
Pulse Source Current (Body Diode) (Note 3)	$I_{SM}$		-	-	56	A
Diode Forward Voltage (Note 2)	$V_{SD}$	$T_J = +25^\circ\text{C}, I_S = 14A, V_{GS} = 0V$	-	-	1.4	V
Reverse Recovery Time	$t_{rr}$	$T_J = +150^\circ\text{C}, I_F = 13A, dI_F/dt = 100A/\mu\text{s}$	-	1300	-	ns
Reverse Recovered Charge	$Q_{RR}$	$T_J = +150^\circ\text{C}, I_F = 13A, dI_F/dt = 100A/\mu\text{s}$	-	7.4	-	$\mu\text{C}$
Forward Turn-on Time	$t_{ON}$	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $L_S + L_D$ .	-	-	-	-

NOTES: 1.  $T_J = +25^\circ\text{C}$  to  $+150^\circ\text{C}$ 2. Pulse Test: Pulse width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$ 

3. Repetitive Rating: Pulse width limited by max. junction temperature. See Transient Thermal Impedance Curve (Figure 5)

4.  $V_{DD} = 50V$ , Start  $T_J = +25^\circ\text{C}$ ,  $L = 7.9\text{mH}$ ,  $R_{GS} = 25\Omega$ ,  $I_{PEAK} = 14A$  (See Figure 15)

### Performance Curves

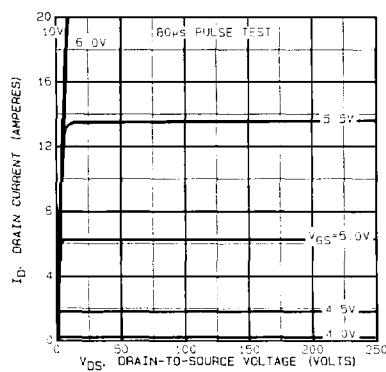


FIGURE 1. TYPICAL OUTPUT CHARACTERISTICS

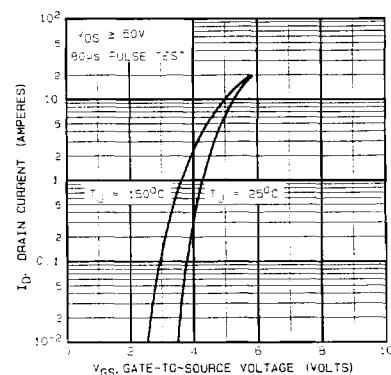


FIGURE 2. TYPICAL TRANSFER CHARACTERISTICS

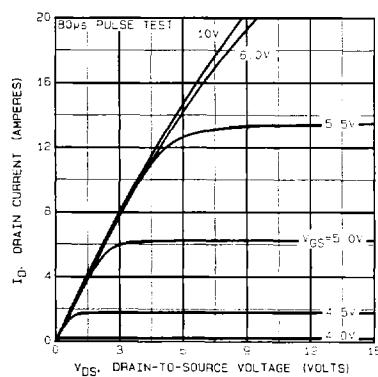


FIGURE 3. TYPICAL SATURATION CHARACTERISTICS

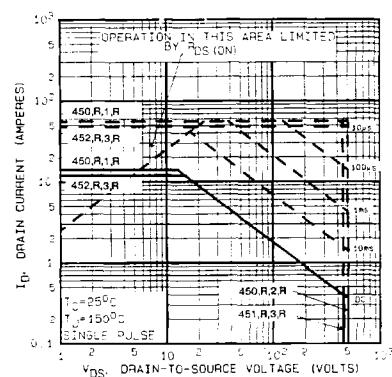


FIGURE 4. MAXIMUM SAFE OPERATING AREA

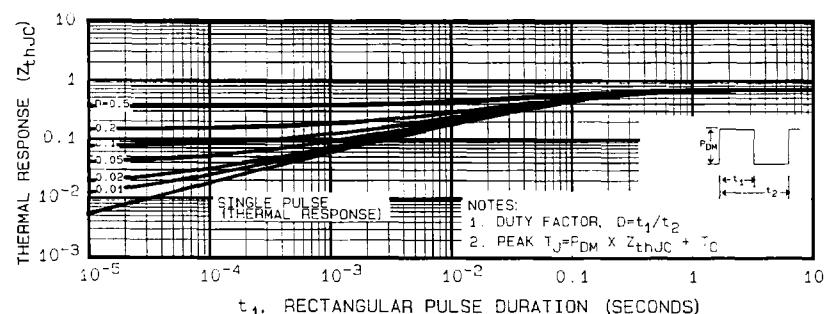
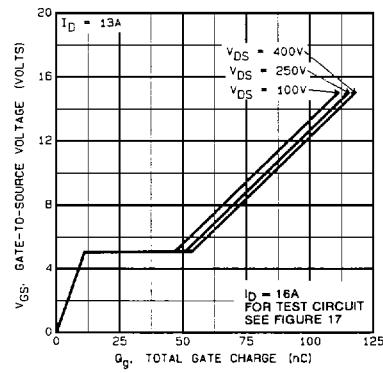
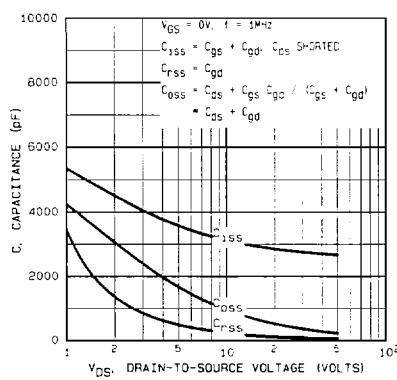
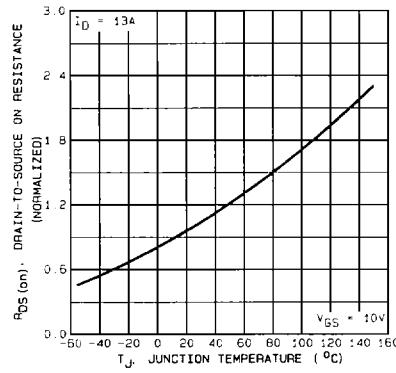
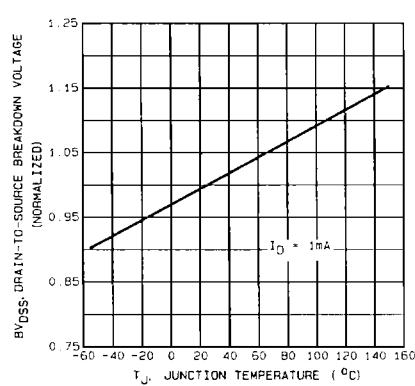
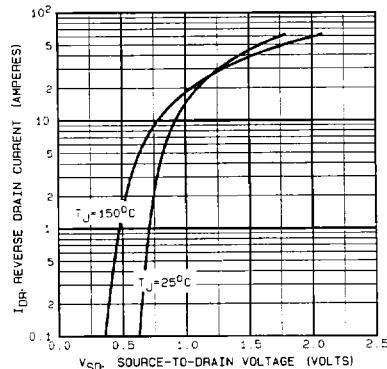
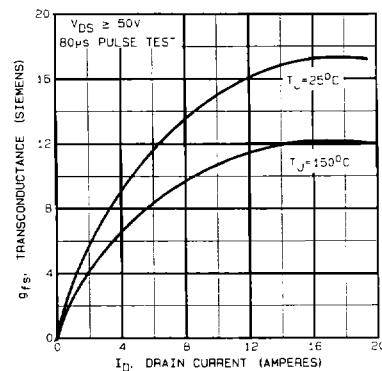


FIGURE 5. MAXIMUM EFFECTIVE TRANSIENT THERMAL IMPEDANCE, JUNCTION-TO-CASE vs PULSE DURATION

**Performance Curves (Continued)**



**Performance Curves (Continued)**

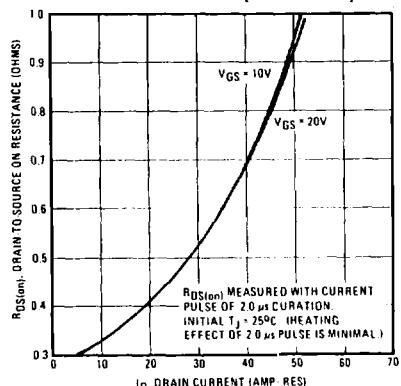


FIGURE 12. TYPICAL ON-RESISTANCE VS. DRAIN CURRENT

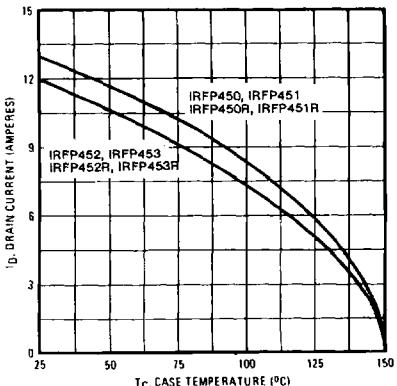


FIGURE 13. MAXIMUM DRAIN CURRENT VS. CASE TEMPERATURE

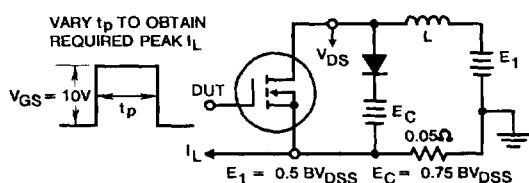


FIGURE 14a. CLAMPED INDUCTIVE TEST CIRCUIT

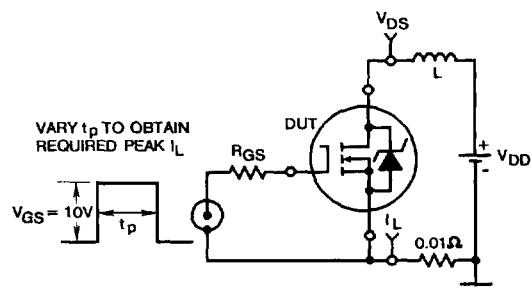


FIGURE 15a. UNCLAMPED ENERGY TEST CIRCUIT

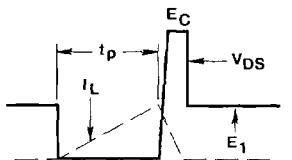


FIGURE 14b. CLAMPED INDUCTIVE WAVEFORMS

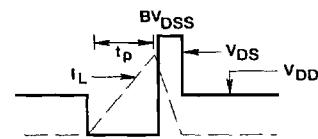


FIGURE 15b. UNCLAMPED ENERGY WAVEFORMS

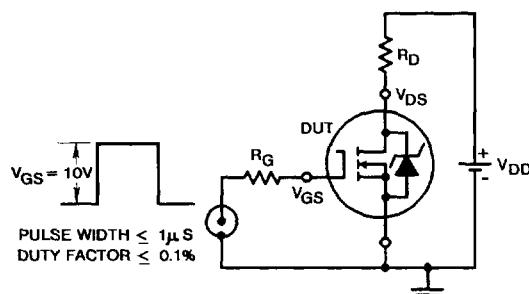


FIGURE 16. SWITCHING TIME TEST CIRCUIT

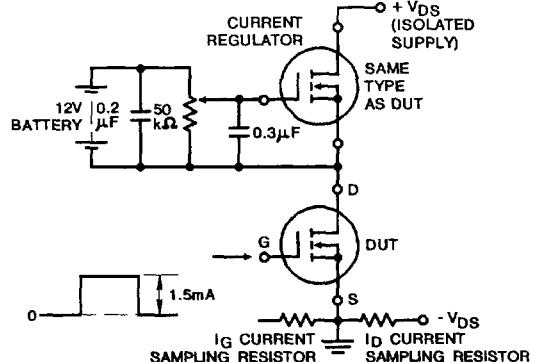


FIGURE 17. GATE CHARGE TEST CIRCUIT